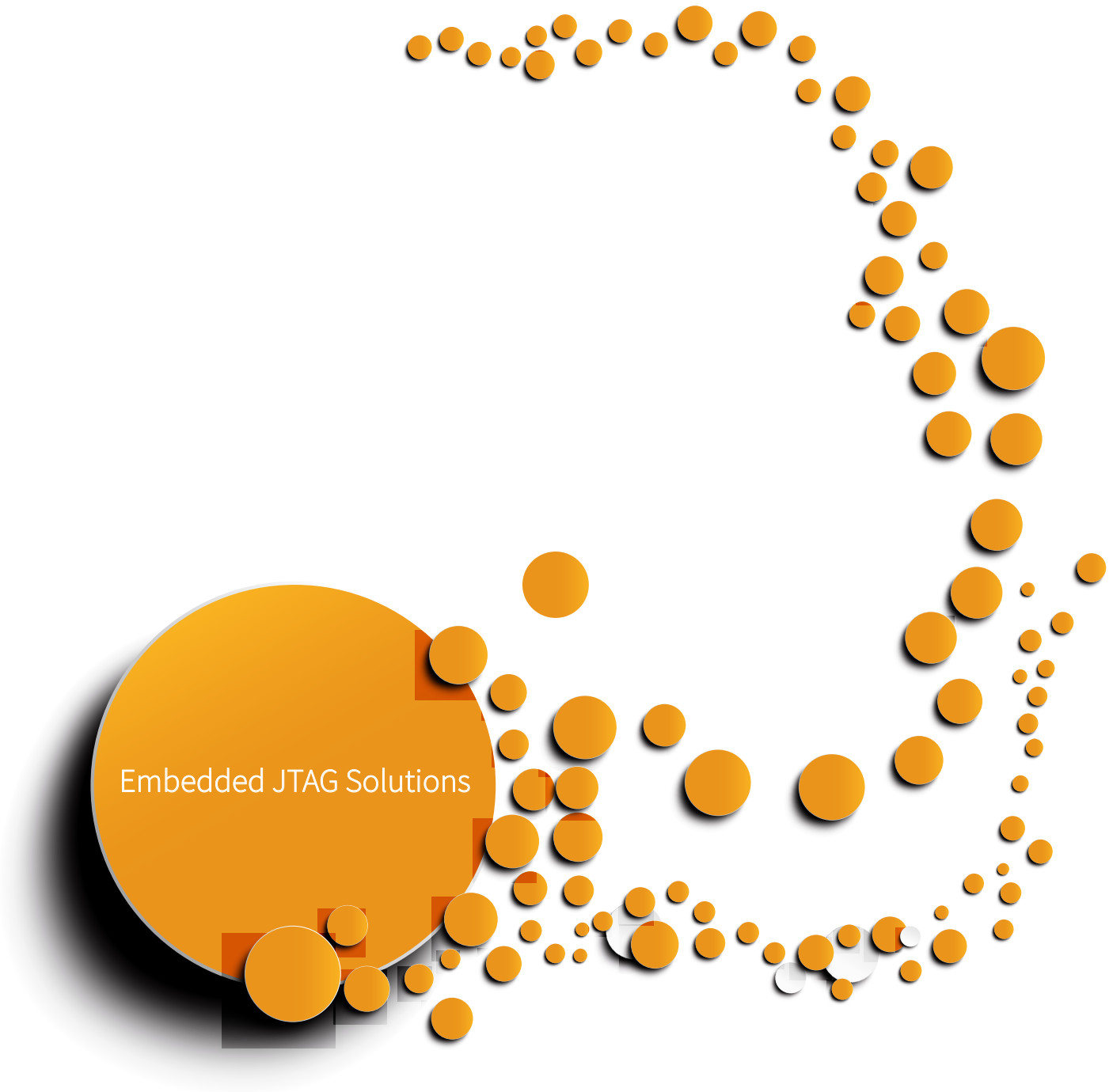
Product overview

Embedded JTAG Solutions



GOPEL electronic

Enjoy Testing

SCANFLEX Controller 1
SCANFLEX Controller for USB/LAN 1
SFX II CUBE 1
SFX II CUBE Mounting Kit 1
SFX II BLADE 4 2
SFX II BLADE 4 Mounting Kit 2
SFX II BLADE 4 RMx1/2/3 3
SFX II BLADE 8 RMx1/2 4
Options for SCANFLEX II controller 4
SFX II WLAN1 4
SFX II TIC01/LX 5
SFX II TIC01 5
SFX II TIC120/LX 5
SFX II TEM 5
SFX II CUBE SPLITTER 6
SCANFLEX controller for PXI Express 6
SFX/PXIe 1149 5
SCANBOOSTER 6
SCANBOOSTER II 6
SCANFLEX for VPC (Virginia Panel Corporation) 7
SFX-TAP6/VPC Adapter/ISO 7
SFX-TAP6/VPC Adapter/Relay 7
SFX/VPC-TAP16/M1 7
SFX/VPC-AMC128L 7
SFX/VPC-AMC128H 8
Options for SCANFLEX TAP transceiver 8
TIC Extension Module (TEM) 8
TEM Splitter 8
TIC Extension Module/Isolated (TEM/ISO) 8
TAP Interface Card (TIC) Type 02/SR 9
TAP Interface Card (TIC) Type 03/SR 9
TAP Interface Card (TIC) Type 02/PMU 9
TAP Interface Card (TIC) Type 022/SR 9
TAP Interface Card (TIC) Type 122/SR 10
TAP Interface Card (TIC) Type 122/XDP60 10
TIC Self Test Board 10
TIC/FXT Self Test Board 10
TAP Isolator 11
SFX TAP for Gang test/programming 11
SFX-TAP16/G-RM 11
SFX-TAP16/G-RM-FXT 11
SFX I/O modules for SCANFLEX und SCANFLEX II. 12
SFX-5296LX 12
SFX-5296 12
SFX-5350 12
SFX-5212 12
SFX-5704 13
SFX-6216 13
SFX-6308 13
CION modules 13
CION module/FXT48A 13
CION module/FXT48AJ 14
CION-LX module/FXT96 14
CION-LX module/FXT192 14
ChipVORX module/FXT-X32/HSIO4 15
ChipVORX module/FXT-X90 15
Solutions & systems 15
Studio versions 15
SCANBOOSTER II Designer Studio Base 15
SCANBOOSTER II Designer Studio Standard 15
SFX II Studio Base 16
SFX II Studio Standard 16
SFX II Studio Comfort 16
JULIET 17
JULIET Series 3 17
JULIET accessories 18
JULIET/Fixture Set 18
JULIET/Barcode Reader Typ A 18
JULIET/Barcode Reader Typ B 18
JULIET/Self testing fixture 18
JULIET/Universal fixture 19
JULIET/Toolset 19
JULIET/Cover Lift 19
JULIET/Cover Lock 19
BARCUDA 20
BARCUDA VPC230 20
RAPIDO 20
RPS910-S16 20
RAPIDO/S16PLUS 20
RAPIDO/Barcode Reader Type A 21
RAPIDO SFT 21
FID (TOP oder BOTTOM) 21
Integration packages 21
Acculogic 21
ATE-Integration for Acculogic Flying Probe 21
VIAVI 22
ATE-Integration for VIAVI MDA/ICT/FKT 22
digitaltest 22
ATE-Integration for Condor Flying Probe digitaltest 22
ATE-Integration for Entry/Vacuum/Cable digitaltest 22
Dr. Eschke 22
ATE-Integration for Dr. Eschke 22
Eiger Design 23
ATE-Integration for Eiger Design 23

Keysight 23
ATE-Integration for Keysight 3070 ICT 23
LxInstruments 23
ATE-Integration for LXinstruments FCT 23
Polar Instruments 23
ATE-Integration for Polar Instruments 23
Reinhardt 24
ATE-Integration for Reinhardt 24
Rohde & Schwarz 24
ATE-Integration for Rohde & Schwarz TSVP 24
Seica 24
ATE-Integration for Seica Flying Probe 24
ATE-Integration for Seica ICT 24
SPEA 25
ATE-Integration for SPEA ICT 25
ATE-Integration for SPEA Flying Probe 25
Takaya 25
ATE-Integration for Takaya APT - Flying Probe 25
Teradyne 25
ATE-Integration for Teradyne Spectrum ICT 25
ATE-Integration for Teradyne Teststation ICT 26
TEST-OK 26
ATE-Integration for TEST-OK 26
TRI 26
ATE-Integration for TRI TR5001 26
Demo kit 26
SYSTEM CASCON Demo kit 26
Accessories 27
VPC modules 27
SFX/VPC-MPP/M1 27
SFX/VPC-TPC128 27
SFX/VPC-PWR16-M1 27
CION-ICs & accessories 27
CION 27
CION-LX 28
Boundary Scan Probe 28
Board Grabber & accessories 28
SFX/Board Grabber-L 28
SFX/Board Grabber-XL 28
SFX/Board Grabber-XXL 29
BG-Nail Probe/RA 29
BG-Access Kit/5 29
BG-Access Kit/10 29
BG-Nail Holders 29
Demoboards 30
Boundary Scan Coach / EZScan 30
GoJTAG Demo Board 30
ESA Coach 30
Integra V1 30
Software 31
CASCON GALAXY-DS Base Edition 31
CASCON GALAXY-DS Standard Edition 31
CASCON GALAXY-DS Classic Edition 32
CASCON GALAXY-DS Advanced Edition 32
CASCON GALAXY-TS Run Time Edition 33
CASCON GALAXY-TS Failure Diagnostic Edition 33
CASCON GALAXY-TS Failure Diagnostic & Repair 34

SCANFLEX controller

SCANFLEX controller for USB/LAN

SFX II CUBE

Multifunctional JTAG/Boundary Scan Controller
for GBit LAN und USB 3.0

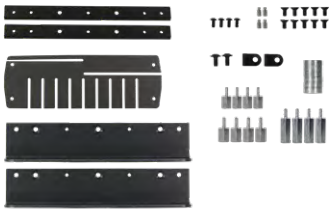
- maximum TCK frequency: 20 MHz / 50 MHz / 100 MHz
- Scan Data Buffer / SPACE™ III Architecture
- ADYCS™ III (Compensation of propagation delays)
- HYSCAN™ (Hybrid Scan, enables the definition of a virtual digital pin electronics)
- FASTSCALE™ (change in the speed level using software, e.g. change to C-controller)
- 2 SFX / LS interfaces (for expansion with SFX carriers and SXF-I/O modules)
- 8 JTAG / TAP slots (SFX II TIC or TEM module must be ordered separately)
- 64 MPP (Multi Purpose Port), mixed-signal I/Os to support 8 TAPs
  - *in-built SFX-I/O module with VarioCore support*
  - *each channel can be configured independently (input, output,*
  - *bidirectional)*
  - *I/O voltage can be programmed in 8 groups, each with 8 channels (0.9-3.6 V)*
  - *driver capability of the channels: +/- 24 mA*
  - *use as generic I/Os, PIP replacement and as control lines in the AFPG (FLASH)*
  - *each signal has a 22O in-line resistor*
- 1 SFX-I/O slot (for expansion with SFX-I/O modules)

Configuration overview · SCANFLEX II CUBE

	SFX II CUBE-A	SFX II CUBE-B	SFX II CUBE-C
item number	SCO2-010	SCO2-011	SCO2-012
max. TCK frequency	20 MHz	50 MHz	100 MHz
data processing	normal - Scan Data Buffer	fast - SPACE™ III architecture (up to 20 times faster)	fast - SPACE™ III architecture (up to 20 times faster)
upgrade	FASTSCALE™ (upgrade to B- or C-controller)	FASTSCALE™ (upgrade to C-controller)	-

Item no. SCO2-xxx

SFX II CUBE Mounting Kit



Installation kit for ATE integration of an SFX II CUBE. With threaded feet for direct installation or for fitting with the magnetic feet included. Strain relief for all cable connections.

Item no. STT2-400

SFX II BLADE 4

SCANFLEX II JTAG/Boundary Scan Controller for GBit LAN and USB 3.0 for average power (without pre-installed TIC / TEM modules)

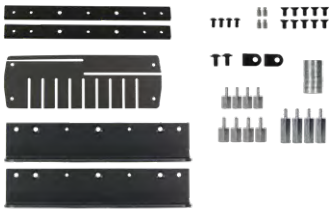
- maximum TCK frequency: 20 MHz / 50 MHz / 100 MHz
- Scan Data Buffer / SPACE™ III Architecture
- ADYCS™ III (Compensation of propagation delays)
- HYSCAN™ (Hybrid Scan, enables the definition of a virtual digital pin electronics)
- FASTSCALE™ (change in the speed level using software, e.g. change to C-controller)
- 2 SFX / LS interfaces (for expansion with SFX carriers and SXF-I/O modules)
- 4 JTAG / TAP slots (SFX II TIC or TEM modules)
- 64 MPP (Multi Purpose Port), mixed-signal I/Os to support 4 TAPs:
  - *in-built SFX-I/O module with VarioCore support*
  - *each channel can be configured independently (input, output, bidi-rectional)*
  - *I/O voltage can be programmed in 8 groups, each with 8 channels (0.9-3.6 V)*
  - *driver capability of the channels +/- 24 mA*
  - *use as generic I/Os, PIP replacement and as control lines in the AFPG (FLASH)*
  - *each signal has a 22O in-line resistor*

Configuration overview · SCANFLEX II BLADE 4

	SFX II BLADE 4-A	SFX II BLADE 4-B	SFX II BLADE 4-C
item number	SCO2-020	SCO2-021	SCO2-022
max. TCK frequency	20 MHz	50 MHz	100 MHz
data processing	normal - Scan Data Buffer	fast - SPACE™ III architecture (up to 20 times faster)	fast - SPACE™ III architecture (up to 20 times faster)
upgrade	FASTSCALE™ (upgrade to B- or C-controller)	FASTSCALE™ (upgrade to C-controller)	-

Item no. SCO2-02x

SFX II BLADE 4 Mounting Kit



Installation kit for ATE integration of an SFX II BLADE 4. With threaded feet for direct installation or for fitting with the magnetic feet included. Strain relief for all cable connections.

Item no. STT2-405

SFX II BLADE 4 RMx3

Up to three independent SCANFLEX II Boundary Scan Controllers for GBit LAN and USB 3.0 (without pre-mounted TIC/TEM modules) for gang applications in a 19″ housing (1 U). The controllers are available in different power levels: medium power: A, high power: B and extremely high power: C.

Features per controller:

- maximum TCK frequency: 20 MHz / 50 MHz / 100 MHz
- Scan Data Buffer / SPACE™ III Architecture
- ADYCS™ III (Compensation of propagation delays)
- HYSCAN™ (Hybrid Scan, enables the definition of a virtual digital pin electronics)
- FASTSCALE™ (change in the speed level using software, e.g. change to C-controller)
- 2 SFX / LS interfaces (for expansion with SFX carriers and SXF-I/O modules)
- 4 JTAG / TAP slots (SFX II TIC or TEM modules must be ordered separately)
- 64 MPP (Multi Purpose Port), mixed-signal I/Os to support 4 TAPs:
  - *in-built SFX-I/O module with VarioCore support*
  - *each channel can be configured independently (input, output, bidirectional)*
  - *I/O voltage can be programmed in 8 groups, each with 8 channels (0.9-3.6 V)*
  - *driver capability of the channels +/- 24 mA*
  - *use as generic I/Os, PIP replacement and as control lines in the AFPG (FLASH)*
  - *each signal has a 22 O in-line resistor*

Configuration overview · SCANFLEX II BLADE 4 RMx1/2/3

	SFX II BLADE 4 RMx1/2/3-A	SFX II BLADE 4 RMx1/2/3-B	SFX II BLADE 4 RMx1/2/3-C
item number	SFX II BLADE 4 RMx1-A: SCO2-110 SFX II BLADE 4 RMx2-A: SCO2-120 SFX II BLADE 4 RMx3-A: SCO2-130	SFX II BLADE 4 RMx1-B: SCO2-111 SFX II BLADE 4 RMx2-B: SCO2-121 SFX II BLADE 4 RMx3-B: SCO2-131	SFX II BLADE 4 RMx1-B: SCO2-112 SFX II BLADE 4 RMx2-B: SCO2-122 SFX II BLADE 4 RMx3-B: SCO2-132
number of controllers	SFX II BLADE 4 RMx1-A: 1 SFX II BLADE 4 RMx2-A: 2 SFX II BLADE 4 RMx3-A: 3	SFX II BLADE 4 RMx1-B: 1 SFX II BLADE 4 RMx2-B: 2 SFX II BLADE 4 RMx3-B: 3	SFX II BLADE 4 RMx1-C: 1 SFX II BLADE 4 RMx2-C: 2 SFX II BLADE 4 RMx3-C: 3
max. TCK frequecy	20 MHz	50 MHz	100 MHz
data processing	normal – Scan Data Buffer	fast - SPACE™ III architecture (up to factor 20 faster)	fast - SPACE™ III architecture (up to factor 20 faster)
upgrade	FASTSCALE (upgrade to B- or C-Controller)	FASTSCALE (upgrade C-Controller)	

Item no. SCO2-13x

SFX II BLADE 8 RMx1/2

Up to two independent SCANFLEX II Boundary Scan Controllers for GBit LAN and USB 3.0 (without pre-mounted TIC/TEM modules) for gang applications in a 19″ housing (1 U). The controllers are available in different power levels: medium power: A, high power: B and extremely high power: C.

Features per controller:

- maximum TCK frequency: 20 MHz / 50 MHz / 100 MHz
- Scan Data Buffer / SPACE™ III Architecture
- ADYCS™ III (Compensation of propagation delays)
- HYSCAN™ (Hybrid Scan, enables the definition of a virtual digital pin electronics)
- FASTSCALE™ (change in the speed level using software, e.g. change to C-controller)
- SFX / LS interfaces (for expansion with SFX carriers and SXF-I/O modules)
- JTAG / TAP slots (SFX II TIC or TEM modules must be ordered separately)
- MPP (Multi Purpose Port), mixed-signal I/Os to support 4 TAPs:
  - *in-built SFX-I/O module with VarioCore support*
  - *each channel can be configured independently (input, output, bidirectional)*
  - *I/O voltage can be programmed in 8 groups, each with 8 channels (0.9-3.6 V)*
  - *driver capability of the channels +/- 24 mA*
  - *use as generic I/Os, PIP replacement and as control lines in the AFPG (FLASH)*
  - *each signal has a 22 O in-line resistor*

Configuration overview · SCANFLEX II BLADE 8 RMx1/2

	SFX II BLADE 8 RMx1/2-A	SFX II BLADE 8 RMx1/2-B	SFX II BLADE 8 RMx1/2-C
item number	SFX II BLADE 8 RMx1-A: SCO2-140 SFX II BLADE 8 RMx2-A: SCO2-150	SFX II BLADE 8 RMx1-B: SCO2-141 SFX II BLADE 8 RMx2-B: SCO2-151	SFX II BLADE 8 RMx1-B: SCO2-142 SFX II BLADE 8 RMx2-B: SCO2-152
number of controllers	SFX II BLADE 8 RMx1-A: 1 SFX II BLADE 8 RMx2-A: 2	SFX II BLADE 8 RMx1-B: 1 SFX II BLADE 8 RMx2-B: 2	SFX II BLADE 8 RMx1-C: 1 SFX II BLADE 8 RMx2-C: 2
max. TCK frequecy	20 MHz	50 MHz	100 MHz
data processing	normal – Scan Data Buffer	fast - SPACE™ III architecture (up to factor 20 faster)	fast - SPACE™ III architecture (up to factor 20 faster)
upgrade	FASTSCALE (upgrade to B- or C-Controller)	FASTSCALE (upgrade C-Controller)	

Item no. SCO2-1xx

Options for SCANFLEX II controller

SFX II WLAN1

- Wireless LAN (WLAN) 150 Mbit/s USB 2.0 Adapter with swivel-mounted and detachable antenna for connection to SFX II controller
- compatible with the IEEE 802.11b/g/n standard
- WPA, WPA2 encryption
- 2,4 GHz frequency band

Item no. SCO2-WLAN1

SFX II TIC01 / LX

TAP Interface Card as a plug-in module for SFX II Controller & SCANBOOSTER II Controller

- 1 JTAG port / TAP with single-ended interface
- programmable input (0.0-3.0 V) and output voltage (0.9-3.6 V)
- programmable input and output impedance
- programmable drive strength
- relay-switched 5 V output signal

Item no. STT2-110

SFX II TIC01 / LX

TAP Interface Card as a plug-in module for SFX II Controller & SCANBOOSTER II Controller

- 1 JTAG port / TAP with single-ended interface
- programmable input (0.0-3.0 V) and output voltage (1.8-4.5 V)
- programmable input and output impedance
- programmable drive strength
- relay-switched 5 V output signal

Item no. STT2-111

SFX II TIC120/ LX

Features:

- 20 pole plug connector
- supported by various debug protocols
  - *JTAG, SWD, SBW, BDM, PIC1x, H/S CSI, SWIM, RS232*
- voltage range 0,9-3,6V
- internal modul

Requirements:

- must be plugged into a SCANFLEX II controller
- CASCON version 4.7.0 or higher

Recommended accessories: SFX II CUBE SPLITTER article no.: (STT2-131)

Item no. STT2-311

SFX II TEM

TIC extension module as a plug-in module for SFX II Controller

- with differential interface for connecting all external TIC modules

Item no. STT2-130

SFX II CUBE SPLITTER

Adapter from a 20-pin high-density socket to two 10-pin low-density plug connectors

- compatible with SFX II TEM, SFX II TEM/ISO and SFX II TIC020/LX of the SFX II CUBE
- for IDC socket assemblies or wire-wrap connections

Item no. STT2-131

SCANFLEX controller for PXI Express

SFX / PXIe 1149

SCANFLEX JTAG/Boundary Scan Controller for PXI Express

- 1 Slot / 3U PXI module
- maximum TCK frequency: 20 MHz / 50 MHz / 80 MHz
- Scan Data Buffer / SPACE™ II Architecture
- ADYCS™ II (Compensation of propagation delays)
- HYSCAN™ (Hybrid Scan, enables the definition of a virtual digital pin electronics)
- FASTSCALE™ (change in the speed level using software, e.g. change to C-controller)
- 1 SFX interface (port for all SCANFLEX TAP transceivers)
- 2 SFX / LS interfaces (for expansion with SFX carriers and SXF-I/O modules)

Configuration overview · SCANFLEX controller for PXI Express

	SFX PXIe-A	SFX PXIe-B	SFX PXIe-C
item number	SCO-050	SCO-051	SCO-052
max. TCK frequency	20 MHz	50 MHz	80 MHz
data processing	normal - Scan Data Buffer	fast - SPACE™ II architecture (up to 10 times faster)	fast - SPACE™ II architecture (up to 10 times faster)
upgrade	FASTSCALE™ (upgrade to B- or C-controller)	FASTSCALE™ (upgrade to C-controller)	-

Item no. SCO-05x

SCANBOOSTER

SCANBOOSTER II

SCANBOOSTER II Boundary Scan Controller for GBit LAN and USB2.0 for moderate performance range (without preassembled TIC/TEM modules)

- maximum TCK frequency: 16MHz
- ADYCS™ III (compensation of propagation delays, without propagation delay measurement)
- 2 JTAG/TAP slots (SFX II TIC or TEM modules must be ordered separately)
- 32 MPP (Multi Purpose Port), mixed signal I/Os to support 2 TAPs
  - *every channel is independent configurable (input, output, bi-directional)*
  - *I/O voltage is programmable (0.9-3.6V) in 4 groups of 8 channels*
  - *driving ability of the channels +/- 24mA*
  - *usage as Generic I/Os, PIP replacement and control lines in the AFPG (FLASH)*
  - *every signal is equipped with a 22 Ohm in-line resistor*

Item no. 111-200

SCANFLEX for VPC (Virginia Panel Corporation)

SFX-TAP6 / VPC Adapter / ISO

- Mass Interconnect Interface for up to 6 TAPs and PIP / MPP signals (SFX-TAP6 / FXT(/ ISO) or SCANFLEX II CUBE with 6 x SFX II TEM(/ ISO))
- based on the 192-pin receiver from Virginia Panel (P / N 510150152)
- support for 2 x 6 x 10-pin and 4 x 12-pin

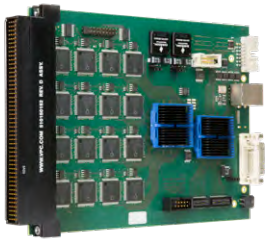
Item no. STT-500

SFX-TAP6 / VPC Adapter / Relay

- Mass Interconnect Interface for up to 6 TAPs and PIP / MPP signals (SFX-TAP6 / FXT(/ ISO) or SCANFLEX II CUBE with 6 x SFX II TEM(/ ISO))
- based on the 192-pin receiver from Virginia Panel (P / N 510150152)
- including support for 2 x 60-pin and 1 x 40-pin

Item no. STT-501

SFX / VPC-TAP16 / M1



Fixture SCANFLEX TAP transceiver for gang applications

- also available as FXT variant (with differential transmission)
- Mass Interconnect Interface for 8 x 2 TAPs (eight TAPs with two TDIs for each TAP)
- 16 built-in TIC020 with multi-bus interface for extended VarioTAP support
- programmable input (0.0-3.0 V) and output voltage (1.8-4.5 V) for each TAP
- programmable input and output impedance for each TAP
- relay-switched 5 V output signal for each TAP when using the SFX / VPC-MPP/ M1 card
- 1 SFX / LS interface (for expansion with SFX carriers and SXF-I/O modules)

*Note: more VPC modules on page 30

Item no. RPD-700

SFX / VPC-AMC128L

SCANFLEX Analog Measurement Card

- 128 independent measuring channels (16 simultaneously)
- VPC interface with 192-pin receiver from Virginia Panel (P/N 510150152)
- 3 measuring ranges: +/-2,5 V, +/-5 V and +/-10 V
- for each of the 128 measuring channels independent, programmable voltage ranges in 3 steps
- control via Gigabit LAN and web interface
- no driver installation required

*Note: more VPC modules on page 30

Item no. RPD-760

SFX / VPC-AMC128H

SCANFLEX Analog Measurement Card

- 128 independent measuring channels (16 simultaneously)
- VPC interface with 192-pin receiver from Virginia Panel (P/N 510150152)
- 3 measuring ranges: +/-2,5 V, +/-5 V and +/-10 V
- for each of the 128 measuring channels independent, programmable voltage ranges in 3 steps
- control via Gigabit LAN and web interface
- no driver installation required

*Note: more VPC modules on page 30

Item no. RPD-761

Options for SCANFLEX TAP transceiver

TIC Extension Module (TEM)

TIC extension module as a plug-in module for Desktop SCANFLEX TAP transceiver 2 / 4 / 6 / 7 / 8S and SCANBOOSTER

- with differential interface for connecting all external TIC modules
- TEM (TIC) cable 0.5 m included

Item no. STT-130

TEM Splitter

Adapter from a 20-pin high-density socket to two 10-pin low-density plug connectors

- plug-on module on SCANFLEX TEM or TEM / ISO
- for IDC socket assemblies or wire-wrap connections

Item no. STT-131

TIC Extension Module / Isolated (TEM / ISO)

TIC extension module / isolated as a plug-in module for Desktop SCANFLEX TAP transceiver 2 / 4 / 6 / 7 / 8S

- with differential and isolated interface for connecting all external TIC modules
- maximum TCK frequency: 65 MHz
- TEM (TIC) cable 0.5 m included

Item no. STT-132

TAP Interface Card (TIC) Type 02 / SR

TAP Interface Card as a fixture assembly module for connection to replaceable or built-in TEM or TEM/ISO

- suitable for all SCANFLEX TAP transceivers, SCANBOOSTER and SCANFLEX II Controller with differential interface (FXT)
- 1 JTAG port / TAP with single-ended interface
- adjustable input (0.0-3.3V, preset to 1.0V or external) and output voltage (1.65-3.6V, preset to 3.3V or external)
- relay-switched 5 V output signal
- cut-off relay for TAP and AUX signals

Item no. STT-121

TAP Interface Card (TIC) Type 03 / SR

TAP Interface Card as a fixture assembly module in a climatic chamber for connection to replaceable or built-in TEM or TEM/ISO

- suitable for all SCANFLEX TAP transceivers, SCANBOOSTER and SCANFLEX II Controller with differential interface (FXT)
- 1 JTAG port / TAP with single-ended interface
- adjustable input (0.0-3.3 V, preset to 1.0 V or external) and output voltage (1.65-3.6 V, preset to 3.3 V or external)
- relay-switched 5 V output signal
- cut-off relay for TAP and AUX signals
- temperature range from -40 °C to 80 °C

Item no. STT-123

TAP Interface Card (TIC) Type 02 / PMU

TAP Interface Card as a fixture assembly module for connection to replaceable or built-in TEM or TEM / ISO

- suitable for all SCANFLEX TAP transceivers and SCANFLEX II Controller with differential interface (FXT)
- 1 JTAG port / TAP with single-ended interface
- adjustable input (0.0-3.3 V, preset to 1.0 V or external) and output voltage (1.65-3.6 V, preset to 3.3 V or external)
- relay-switched 5 V output signal
- cut-off relay for TAP and AUX signals
- additionally built-in precision-measuring unit (PMU) for unpowered open / short tests
- can be used with PXI or SCANFLEX I/O modules

Item no. STT-124

TAP Interface Card (TIC) Type 022 / SR

TAP Interface Card as a fixture assembly module for connection to replaceable or built-in TEM or TEM / ISO

- suitable for all SCANFLEX TAP transceivers and SCANFLEX II Controller with differential interface (FXT)
- 1 JTAG port / TAP with single-ended interface
- adjustable input (0.0-3.3 V, preset to 1.0 V or external) and output voltage (1.65-3.6 V, preset to 3.3 V or external)
- relay-switched 5 V output signal
- cut-off relay for TAP and AUX signals
- with multi-bus interface for extended VarioTAP support

Item no. STT-126

TAP Interface Card (TIC) Type 122 / SR

TAP Interface Card as a fixture assembly module for connection to replaceable or built-in TEM or TEM / ISO

- suitable for all SCANFLEX TAP transceivers und SCANFLEX II Controller with differential interface (FXT)
- 1 JTAG port / TAP with single-ended interface
- adjustable input (0.0-3.3 V, preset to VOUT / 2 or external) and output voltage (0.9-3.6 V, fixed at 3.3 V or external, present to external)
- relay-switched 5 V output signal
- cut-off relay for TAP and AUX signals
- with multi-bus interface for extended VarioTAP support
- support for Intel architecture

Item no. STT-134

TAP Interface Card (TIC) Type 122 / XDP60

Special impedance-controlled connection cable for TIC122 / S(R) for connection to the Intel XDP60 Debug plug connector

Item no. STT-135

TIC Self Test Board

Self-testing module for JTAG / TAP signals

- Plug-in card for standard 10-pin TAP connector of the TIC modules

Item no. STT-115

TIC / FXT Self Test Board

Self-testing module for JTAG / TAP signals

- for fixture applications
- 7 cables with female connectors, with terminals for contacting the transceiver contacts or ICT pins included

Item no. STT-116

TAP Interface Card (TIC) Type 020

TAP Interface Card as a plug-in module for Desktop SCAN-FLEX TAP transceiver 2 / 4 / 6 / 7 / 8

- 1 JTAG port / TAP with single-ended interface
- programmable input (0.0-3.0 V) and output voltage (1.8-4.5 V)
- programmable input and output impedance
- relay-switched 5 V output signal
- TIC cable 0.5 m included
- with multi-bus interface for extended VarioTAP support

Item no. STT-310

TAP Isolator

External Desktop Box for isolating TAP signals between primary interface and target

- selectable output voltage (2.5 V, 3.3 V or adjustable 1.65-4.5 V)
- maximum TCK frequency: 65 MHz
- TAP cable included
- external 5 V power supply required

Item no. STT-910

SCANFLEX TAP transceiver for gang testing and programming

SFX-TAP16 / G-RM

SCANFLEX TAP transceiver for gang applications in a 19″ housing (1U)

- 8 x 2 TAPs (eight TAPs with two TDIs for each TAP)
- 16 built-in TIC020 with multi-bus interface for extended VarioTAP support
- programmable input (0.0-3.0 V) and output voltage (1.8-4.5 V)

Item no. STT-700

SFX-TAP16 / G-RM-FXT

SCANFLEX TAP transceiver for gang applications in a 19″ housing (1U)

- 8 x 2 differential TAPs (eight TAPs with two TDIs for each TAP)
- 16 built-in TEM modules
- an external differential TIC module is required for each TAP used (not included)

Item no. STT-710

SFX I/O modules for SCANFLEX und SCANFLEX II

SFX-5296LX

SCANFLEX digital I/O module (mixed signal)

- 96 single-ended (SE) test channels in 3 x 32-bit groups; I/O voltage per group: 0.9-3.6 V; driver capability of the channels: +/- 24 mA
- I/O voltage is programmable for any group
- each channel can be configured independently (input, output, bi-directional) and supports the unstress function
- extended test resources at the I/O pins (SE):
  - *12-bit ADC + 1k RAM (signal recorder)*
  - *10-bit DAC + 1k RAM (arbitrary waveform generator)*
  - *event detector*
  - *frequency meter*
  - *connectable pull-up and pull-down resistors (each 10k)*
  - *setting for the drive strength*

Item no. SMO-001

SFX-5296

SCANFLEX digital I/O module

- 96 single-ended (SE) test channels in 3 x 32-bit groups; I/O voltage per group: 0.9-3.6 V; driver capability of the channels: +/- 24 mA
- each channel can be configured independently (input, output, bi-directional and tri-state)
- I/O voltage is programmable for any group

Item no. SMO-000

SFX-5350

SCANFLEX digital I/O module

- 50 differential test channels
- standard interface: LVDS (can be changed by a module update)
- driver capability of the channels is dependent on the I/O standard
- each channel can be configured independently (input, output, bi-directional and tri-state)

Item no. SMO-005

SFX-5212

SCANFLEX digital I/O module

- 12 single-ended (SE) test channels in 1 x 12-bit groups; I/O voltage per group: 12 / 24 V internal or 8-30 V external; driver capability of the channels: +/- 150 mA (@ external)
- I/O voltage is programmable for any group
- each channel can be configured independently (input, output, bi-directional and tri-state)

Item no. SMO-008

SFX-5704

SCANFLEX mixed-signal I/O module

- 4 single-ended (SE) test channels in 4 x 1-bit groups; I/O voltage per group: -10 - +10 V; driver capability of the channels: +/- 300 mA
- I/O voltage is programmable for any group
- each channel consists of a driver / sensor stage
- 12-bit ADC for discrete recording of measurement values
- cut-off relay for galvanic isolation of the driver / sensor channels
- can be used in conjunction with SFX carrier 5, SFX-TAP8 or SFX-TAP8 / FXT (module must support 48 V, see documentation)
- external 48 V power supply (P / N STT-900) required

Item no. SMO-011

SFX-6216

SCANFLEX analogue measuring module

- 16 analogue measurement channels with cut-off relay for galvanic isolation
- 12-bit ADC with 4 channels (250 kSPS) enables simultaneous measurement of 4 of the 16 channels
- programmable ±50 V and ±5 V voltage range per channel
- input impedence > 1 MOhm

Item no. SMO-026

SFX-6308

SCANFLEX analogue I/O module, operation only with SFX carriers and SFX-TAP8

- 4 analogue measurement and driver channels with cut-off relay for galvanic isolation
- output voltage channels and measurement inputs have a voltage resolution of 12 bit in a range between –10 V and +10 V
- input impedence > 1 MOhm
- 8 digital I/O pins can be used as external trigger inputs

Item no. SMO-121

CION modules

CION Module / FXT48A

JTAG/Boundary Scan I/O module (mixed signal)

- 48 single-ended (SE) Boundary Scan test channels in 2 x 8-bit groups and 2 x 16-bit groups; I/O voltage per group: 1.8-5.0 V; driver capability of the channels: +/- 24 mA
- I/O voltage fixed on the board: 3.3 V
- I/O voltage is adjustable for any group
- each channel can be configured independently (input, output, bidirectional) and supports the unstress function
- maximum TCK frequency: 33 MHz
- 4 ADC channels (0-5 V) / 2 ADC channels (0-10 V) / 2 ADC channels (0-30 V)
- 4 DAC channels (10 bit, 0-4,096 V)
- 2 optically isolated digital inputs / 2 optically isolated digital outputs
- 1 RS485 transceiver / 2 RS232 transceiver
- cascadable

Item no. 340-023

CION-LX Module / FXT48AJ

JTAG/Boundary Scan I/O module

- 48 Boundary Scan test channels, provided by CION-LX ICs
- logic level adjustable from 0.9 V to 3.6 V in four groups (2x16 and 2x8 bit)
- driver capability of the channels: ±24 mA at 3.3 V
- CION-LX has extended test resources that are available at the 48 I/O pins:
  - *12-bit ADC (signal recorder)*
  - *10-bit DAC (arbitrary waveform editor)*
  - *event detector*
  - *frequency meter*
  - *connectable pull-up and pull-down resistors of 10 kOhm each*
  - *setting for the drive strength*
- driver capability of the channels: ±24 mA
- a 12-bit AD converter LTC2309
- 4 ADC channels (0-5 V) / 2 ADC channels (0-10 V) / 2 ADC channels (0-30 V)
- 2 10-bit DA converters / 2 DAC channels (0-4,096 V)
- 2 optically isolated digital inputs / 2 optically isolated digital outputs
- 1 RS485 transceiver / 2 RS232 transceivers
- cascadable

Item no. CLXM-003

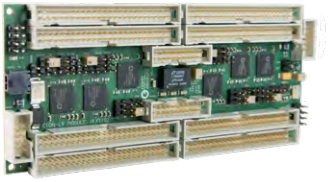
CION-LX Module / FXT96

JTAG/Boundary Scan I/O module (mixed signal)

- 96 single-ended (SE) Boundary Scan test channels in 3 x 32-bit groups; I/O voltage per group: 0.9-3.6 V; driver capability of the channels: +/- 24 mA
- 12 high-current (HC) Boundary Scan test channels in 1 x 12-bit group; I/O voltage per group: 0.9-2.0 V; driver capability of the channels: +/- 40 mA
- 24 differential (DE) Boundary Scan test channels in 1 x 24-bit group; LVDS or CML; with full support for IEEE1149.6
- I/O voltage fixed on the board: 3.3 V, 2.5 V, 1.2 V
- I/O voltage is adjustable for any group
- each channel can be configured independently (input, output, bidirectional) and supports the unstress function
- maximum TCK frequency: 100 MHz
- extended test resources at the I/O pins:
  - *12-bit ADC + 1k RAM (signal recorder) at SE and HC pins*
  - *10-bit DAC + 1k RAM (arbitrary waveform generator) at SE and HC pins*
  - *event detector at all pins*
  - *frequency meter at all pins*
  - *connectable pull-up and pull-down resistors (each 10k) at SE and HC pins*
  - *setting for the drive strength at SE and HC pins*

Item no. CLXM-000

CION-LX Module / FXT192



JTAG/Boundary Scan I/O module (mixed signal)

- 192 single-ended (SE) Boundary Scan test channels in 6 x 32-bit groups; I/O voltage per group: 0.9-3.6 V; driver capability of the channels: +/- 24 mA
- 24 high-current (HC) Boundary Scan test channels in 2 x 12-bit groups; I/O voltage per group: 0.9-2.0 V; driver capability of the channels: +/- 40 mA
- 48 differential (DE) Boundary Scan test channels in 2 x 24-bit groups; LVDS or CML; with full support for IEEE1149.6
- I/O voltage fixed on the board: 3.3 V, 2.5 V, VI/O (default 1.2 V)
- I/O voltage is adjustable for any group

- each channel can be configured independently (input, output, bidirectional) and supports the unstress function
- maximum TCK frequency: 100 MHz
- extended test resources at the I/O pins:
  - *12-bit ADC + 1k RAM (signal recorder) at SE and HC pins*
  - *10-bit DAC + 1k RAM (arbitrary waveform generator) at SE and HC pins*
  - *event detector at all pins*
  - *frequency meter at all pins*
  - *connectable pull-up and pull-down resistors (each 10k) at SE and HC pins*
  - *setting for the drive strength at SE and HC pins*

Item no. CLXM-002

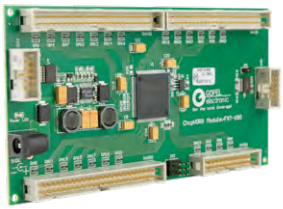
ChipVORX Module / FXT-X32 / HSIO4

ChipVORX module for testing high-speed interfaces

- 4 Slots for interface adapter cards for high-speed I/O test (incl. bit error rate test), each with 2 serial high-speed transceivers with maximum 6.6 Gbit/s
- 32 Boundary Scan test channels with 3.3 V (no 5.0 V I/O tolerance), provided by a freely programmable Xilinx Kintex-7 FPGA
- driver capability of the channels max. ±16 mA
- universal 32 MHz and 100 MHz clock generators
- special support for ChipVORX technology
- additional four SPI configuration memories

Item no. CXIO-030

ChipVORX Module / FXT-X90



ChipVORX I/O module with configurable FPGA

- 90 Boundary Scan test channels, provided by a freely programmable Xilinx Spartan-6 FPGA
- Logic level adjustable from 1.2 V to 3.3 V for 76 channels (no 5.0 V I/O tolerance)
- fixed logic level for 14 channels with 3.3 V (no 5.0 V I/O tolerance)
- the data transmission direction of each test channel can be freely programmed
- driver capability of the channels max. ±24 mA
- universal 32 MHz clock generator
- special support for ChipVORX technology

Item no. CXIO-010

Solutions & systems

Studio versions

SCANBOOSTER / USB Designer Studio Base

System components in the hardware / software bundle:

- SCANBOOSTER / USB (2 TAP Version)
- CASCON GALAXY-DS Base / SX Edition incl.
- portable licence via USB, no floating licence
- software maintenance contract for one year (SMC)

Item no. SHB-020

SCANBOOSTER / USB Designer Studio Standard

System components in the hardware / software bundle:

- SCANBOOSTER / USB (2 TAP Version)
- CASCON GALAXY-DS Standard / SX Edition incl.
- portable license via USB
- software maintenance contract for one year (SMC)

Item no. SHB-021

SFX II Studio Base

SCANFLEX II Designer Studio Base

- SFX II CUBE Controller - Speedgrade A incl. 2 x multi-bus connections (JTAG, SWD, etc.)
- goJTAG Demo Board
- CASCON GALAXY Development Station Base
- licence via USB dongle
- software maintenance contract for one year (SMC)

Item no. SHB-040

SFX II Studio Standard

SCANFLEX II Designer Studio Base

- SFX II CUBE Controller - Speedgrade A incl. 2 x multi-bus connections (JTAG, SWD, etc.)
- goJTAG Demo Board
- CASCON GALAXY Development Station Standard / SX
- licence via USB dongle
- software maintenance contract for one year (SMC)

Item no. SHB-041

SFX II Studio Comfort

SCANFLEX II Designer Studio Standard Comfort

- SFX II CUBE Controller - Speedgrade A incl. 4 x multi-bus connections (JTAG, SWD, etc.)
- goJTAG Demo Board
- CASCON GALAXY Development Station Standard / SX
- layout Data Import (1 format) and visualisation
- licence via USB dongle
- software maintenance contract for one year (SMC)

Item no. SHB-042

JULIET

JULIET Series 3

Compact Embedded JTAG Solutions tester as a desktop system. Suitable for development and production, with integrated system electronics. Controlled from an external PC or laptop via USB 3.0 or Gbit LAN.

Mechanics

- compact, portable desktop model
- solid mechanics with manual loading and unloading
- Bed of nails as interchangeable cassette
- two-sided adaptation to test points and plug connectors
- LED display for test results
- controlled via operator panel on the device
- extended access protection
- access to all test resources via front interface during testing
- Tester Link Software
- online PASS / FAIL statistics
- optional MES interface

Tester interface

- 4 power supplies (internal / external)
- 4 test access ports (TAP) up to 50 MHz
- 192 mixed signal I/O channels
- 16 differential channels with IEEE1149.6 support
- 8 electrically isolated inputs / 8 electrically isolated outputs
- 32 Multi Purpose Ports (MPP)
- 32 ADC channels / 16 DAC channels
- 8 RS232 interfaces / 84 RS485 interfaces
- adapter coding 7 bit / I^2C EEPROM
- cover monitoring
- power management
- 4 controllable power rails
- internal fixed voltages of 3.5 V, 5 V and 12 V
- current / voltage measurement for up to 4 UUTs
- discharge function
- external sense support
- current monitoring and shutdown

SCANFLEX II hardware

- SFX II CUBE-B
- SFX II TIC020 / LX (x4)

PCB handling

- max. board dimensions: 340 mm x 230 mm
- max. number of pins: 600 (1N)

Configuration overview · JULIET Series 3

	JULIET Series 3/RTS	JULIET Series 3/FDS	JULIET Series 3/DRS
item number	JLT-040	JLT-041	JLT-042
JTAG chains	4 (max. 50 MHz)	4 (max. 50 MHz)	4 (max. 50 MHz)
software	Test Station run-time	Test station failure diagnostic	Test station failure diagnostic & repair
I/O channels	192 - Mixed Signal	192 - Mixed Signal	192 - Mixed Signal
ADC channels	32	32	32
VarioTAP/ChipVORX/JEDOS support	yes - full	yes - full	yes - full
PC connection	USB 2.0 or Gbit Ethernet	USB 2.0 or Gbit Ethernet	USB 2.0 or Gbit Ethernet
data processing	fast - SPACE™ II architecture	fast - SPACE™ II architecture	fast - SPACE™ II architecture
power supply (internal/external)	4	4	4

Item no. JLT-04x

JULIET accessories

JULIET / Fixture Set

Original adapter including hold-down panel, pin support, moving plate, sleeve protector plate, hold-down device, board rests and interface labels.

Item no. JLT-000

JULIET / Barcode Reader Type A

Manual barcode reader for 1D codes (Datalogoc Gryphon GD4130-BK), others available on request.

Item no. JLT-003

JULIET / Barcode Reader Type B

Manual barcode reader for 2D codes (Honeywell Xenon 1900GSR-2), others available on request.

Item no. JLT-102

JULIET / Self-testing fixture

Self-testing adapter with active self-testing electronics, including adapter box. Can also be used with restrictions for JULIET Series 2.

Item no. JLT-004

JULIET / Universal Fixture

Self-testing adapter with active self-testing electronics, including adapter box. Can also be used with restrictions for JULIET Series 2.

Item no. JLT-005

JULIET / Toolset

Tool kit for JULIET, including CION module and wearing parts package.

Item no. JLT-009

JULIET / Cover Lift

Pneumatic cylinder for automatically opening the cover once the test procedure is finished. (This option serves exclusively for opening the cover and cannot be retro-fitted.)

Item no. JLT-100

JULIET / Cover Lock

Pneumatic cylinder for automatically locking the cover during the test procedure. (This option cannot be retrofitted and serves exclusively to protect the test system and the assembly. Not suitable as a safety lock.)

Item no. JLT-101

BARCUDA

BARCUDA VP230

Embedded JTAG tester for 16 assemblies

- 19 inch rack with slide-in modules and VPC interface
- 12 U rack from Schroff with VPC Gemini Interface 12
- Industrial PC desktop version
- TFT Monitor 21.5 Zoll

Tester software

- CASCON Galaxy-TS Failure Diagnostic Edition (FDE)
- Tester Link Software for Embedded JTAG Solutions
- Software Maintenance Contract (SMC)

Tester hardware

- SXF/PCIe 1149-B
- SFX/VPC-TAP16/M1
- SFX/VPC-MPP/M1
- SFX/VPC-PWR16/M1
- SFX/VPC-TPC128
- SFX/VPC-AMC128

Art.-Nr. BCD-100

RAPIDO

RPS910-S16

In-line programming station for 16 assemblies incl. in-line handler

- 17 VPC slots below / 6 VPC slots above
- belt module with automatic width adjustment from 60 to 250 mm
- IPC-SMEMA-9851 interface (other available on request)
- PC system
- touchscreen monitor
- in-built industrial PC
- power supply
- uninterrupted power supply (UPS) for the whole system
- 3-channel power supply unit for supplying assemblies and adapters
- 5 V / 24 V system voltage in the adapter
- SCANFLEX hardware
- SFX / PCI-1149-B Controller Card
- SFX / VPC tranceiver card for 16 TAPs
- SFX / VPC multipurpose card with 128 channels
- SFX / VPC power card for supplying up to 16 assemblies
- PCB handling
- board dimensions: 60 x 60 mm to 400 x 250 mm
- max. height of the components – top: 60 mm, underside: 20 mm
- max. PCB weight: 1500 g
- max. number of pins: 900 (above and below)

Item no. RPD-130

RAPIDO / S16PLUS

Upgrade kit for additional 16 assemblies for testing and programming. Complete set with controller, transceiver, multipurpose (MPP), power card, SFT hardware and software licences, incl. installation for new machines.

Item no. RPD-001

RAPIDO / Barcode Reader Type A

System-integrated barcode reader for 2D labels (Microscan MicroHAWK ID-30), others available on request.

Item no. RPD-004

RAPIDO SFT

Interchangeable self-testing adapter for all RAPIDO models with active self-testing electronics and FID (recommended).

Item no. RPD-005

FID (TOP or BOTTOM)

Fixture Identification and Data module (FID) for lower and upper adapters. Intelligent counter module with project-specific data storage, maintenance history and output for maintenance requests, including FID configuration software

Item no. RPD-009/010

Integration packages

Acculogic

ATE integration for Acculogic Flying Probe

ATE integration packages advanced for Acculogic Flying Probe

Item no. IP-ACxxx-x

VIAVI

ATE integration for VIAVI MDA/ICT/FKT

ATE integration packages for VIAVI 42xx / 52xx and 58xx

Item no.	IP-VIxx-x

digitaltest

ATE integration for digitaltest Condor Flying Probe

ATE integration packages for digitaltest MTS500 / MTS505 Condor

Item no.	IP-DTPxx-x

ATE integration for digitaltest ICT Entry / Vacuum / Cable

ATE integration package Base for digitaltest MTS30 / MTS180 / MTS300 / MTS888 / Sprint

Item no.	IP-DTxxx-x

Dr. Eschke

ATE integration for Dr. Eschke

ATE integration package for Dr. Eschke CT300 / CT350

Item no.	IP-DR3xx-x

Eiger Design

ATE integration for Eiger Design

ATE integration package for Eiger Design J-tester

Item no.	IP-EDJxx-x

Keysight

ATE integration for Keysight 3070 ICT

ATE integation packages for Keysight HP3070 / 3070 / i3070/ i5000/ Utility Card / Slot / Performance Port

Item no.	IP-KExxx-x

LXinstruments

ATE integration for LXinstruments FCT

ATE integration package for LXinstruments function tester

Item no.	IP-LXIxx-x

Polar Instruments

ATE integration for Polar Instruments

ATE integration package for Polar Instruments (GRS500) / GRS550

Item no.	IP-PI5xx-x

Reinhardt

ATE integration for Reinhardt

ATE integration package for Reinhardt ATS-(U)KMFT

Item no.	IP-RHAxx-1

Rohde & Schwarz

ATE integration for Rohde & Schwarz TSVP

ATE integration package for Rohde & Schwarz TSVP

Item no.	IP-RSTxx-1

Seica

ATE integration for Seica Flying Probe

ATE integration for Seica Pilot H4 / L4 / M4 / V8

Item no.	IP-SECxx-1

ATE integration for Seica ICT

ATE integration Base for Seica Compact SL / TK / Multi

Item no.	IP-SECxx-1

SPEA

ATE integration for SPEA ICT

ATE integration for SPEA 3030 ICT

Item no	IP-SP3xx-x

ATE integration for SPEA Flying Probe

ATE integration for SPEA Flying Prober 4020 / 4040 / 4050 / 4060 / 4080

Item no	IP-SPxxx-x

Takaya

ATE integration for Takaya APT - Flying Probe

ATE integration for Takaya APT94xx / 96xx / 1400F

Item no.	IP-TKxxx-x

Teradyne

ATE integration for Teradyne Spectrum ICT

ATE integration package for Teradyne Spectrum / 88xx / TSSE

Item no.	IP-TD8xx-x

ATE integration for Teradyne Teststation ICT

ATE integration package for Teradyne Teststation TS / 12x / TSLH / TSLX / TSI052 / GR228x

Item no. IP-TD8xx-x

TEST-OK

ATE integration for TEST-OK

ATE integration package for TEST-OK UCM Expansion Board

Item no. IP-TOKxx-1

TRI

ATE integration for TRI TR5001

ATE integration package for TRI TR5001

Item no. IP-TR5xx-x

Demo kit

SYSTEM CASCON Demo kit

Complete tool kit

- Boundary Scan Controller PicoTAP
- USB cable
- goJTAG Demo Board
- CASCON GALAXY Advanced Edition, restricted to use with the goJTAG Demo Board included
- compatible with Windows 7 / 8.x / 10 (32 / 64 bit)
- USB dongle

Item no. TAS-011

Accessories

VPC modules

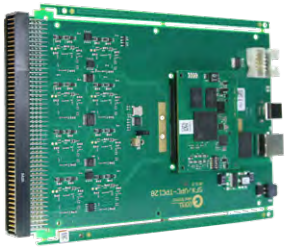
SFX / VPC-MPP / M1

Fixture SCANFLEX digital I/O module for gang applications

- Mass interconnect interface for 128 MPP (Multi Purpose Port) signals (16 groups x 8 MPP signals) to support 16 TAPs
- each channel can be configured independently (input, output, bi-directional)
- I/O voltage can be programmed in 16 groups, each with 8 channels (1.8-4.5 V)
- driver capability of the channels +/- 24 mA
- use as generic I/Os, test channels, PIP replacement and as control lines in the AFPG (FLASH)
- each signal has a 22O in-line resistor

Item no. RPD-720

SFX / VPC-TPC128



SCANFLEX Test Pattern Card

- 128 I/O channels (16 groups of 8 I/O signals each for up to 16 UUTs)
- 8 additional PIO channels
- VPC interface with 192 Pin Receiver from Virgina Panel (P/N 510150152)
- control via Gigabit LAN and web interface
- no driver installation required

Item no. RPD-721

SFX / VPC-PWR16-M1

Fixture SCANFLEX power control for gang applications

- Mass interconnect interface with support for eight UUTs with four (8 x 4) voltages or 16 UUTs with two (16 x 2) voltages
- based on the 192-pin receiver from Virginia Panel (P/N 510150152)
- voltage range max. +/-20 V with 2A based on mass (for each voltage of a UUT)
- arranged in a 2 x 2 x 8 matrix (8 times 2 relays, each with 2 voltages, one relay therefore always switching 2 voltages)
- measurement of the input voltages
- excess current detection and automatic shutdown possible on every UUT
- output voltages are defined by external power supply
- controlled via SFX/LS power bus when using an SFX/VPC- TAP16/M1
- constrolled via USB (mini USB socket) when using other SFX transceivers
- external power supply required

Item no. RPD-740

CION ICs & accessories

CION

Configurable PIO module

- with extended IEEE1149.1 architecture
- 4 operating modes (Boundary Scan, PIO, PXI, driver)
- 32 single-ended (SE) Boundary Scan test channels in 4 x 8-bit ports; I/O voltage per port: 1.8-5.0 V; driver capability of the channels: +/- 24mA

Item no. 331-001

CION-LX

Configurable PIO module

- 11 operating modes (Boundary Scan, PIO, PXI, driver)
- 32 single-ended (SE) Boundary Scan test channels in 4 x 8-bit ports; I/O voltage per port: 0.9-3.6 V; driver capability of the channels: +/- 24 mA
- 4 high-current (HC) Boundary Scan test channels in 1 x 4-bit port; I/O voltage: 0.9-2.0 V; driver capability of the channels: +/- 40 mA
- 8 differential (DE) Boundary Scan test channels in 1 x 8-bit group; LVDS or CML; with full support for IEEE1149.6
- each channel can be configured independently (input, output, bidirectional) and supports the unstress function
- simultaneous driving and measurement of all I/Os
- maximum TCK frequency: 100 MHz
- extended test resources at the I/O pins:
  - *12-bit ADC + 1k RAM (signal recorder) at SE and HC pins*
  - *10-bit DAC + 1k RAM (arbitrary waveform generator) at SE and HC pins*
  - *event detector at all pins*
  - *frequency meter at all pins*
  - *connectable pull-up and pull-down resistors (each 10k) at SE and HC pins*
  - *setting for the drive strength at SE and HC pins*
- 116-pin LGA housing 11 mm x 11 mm

Item no. CLX-001

Boundary Scan Probe

Logic tester

- JTAG / Boundary Scan (TAP) Interface
- JTAG / Boundary Scan Signal Emulation
- with Drive / Sense – electronics
- spot lighting
- toggle function
- status LED

Item no. 312-000

Board grabber & accessories

SFX / Board Grabber-L

- total size: 470 x 505 x 160 mm
- frame size: 400 x 300 mm
- for a PCB size of up to 285 x 235 x 4 mm when the rails are used vertically
- for a PCB size of up to 335 x 185 x 4 mm when the rails are used horizontally

Item no. SUF-010

SFX / Board Grabber-XL

- total size: 570 x 605 x 160 mm
- frame size: 500 x 400 mm
- for a PCB size of up to 385 x 335 x 4 mm when the rails are used vertically
- for a PCB size of up to 435 x 285 x 4 mm when the rails are used horizontally

Item no. SUF-020

SFX / Board Grabber-XXL

- total size: 670 x 705 x 160 mm
- frame size: 600 x 500 mm
- for a PCB size of up to 485 x 435 x 4 mm when the rails are used vertically
- for a PCB size of up to 535 x 385 x 4 mm when the rails are used horizontally

Item no. SUF-030

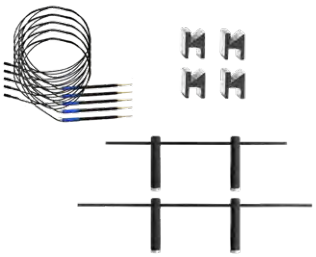
BG-Nail Probe / RA

For all SFX / Board Grabber

- 1 rectangular pin (black colour) with 0.5 m cable and with magnetic feet (stand-alone)

Item no. SUF-000

BG-Access Kit / 5

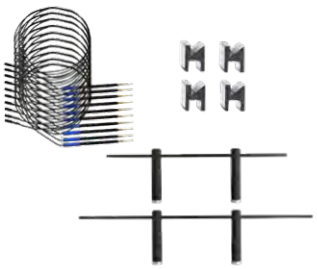


BG-Access Kit / 5 for board grabbers

- 5 pins (each with a different colour)
- 550 mm cable
- includes 2 rails
- 4 board holders

Item no. SUF-001

BG-Access Kit / 10



BG-Access Kit / 10 for board grabbers

- 10 pins (5 black and 5 in various colours)
- 550 mm cable
- includes 2 rails
- 4 board holders

Item no. SUF-002

BG-Nail Holders

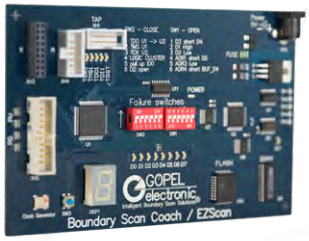
BG-Nail Holders

- BG / Nail Holders for board grabber
- rails and magnetic holders for additional pins

Item no. SUF-003

Demo boards

Boundary Scan Coach / EZScan

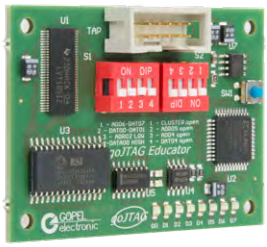


Simple training board for mastering Boundary Scan technology

- 2 Boundary Scan ICs (CPLD)
- Fault switch
- LED
- Buffer
- Logic
- RAM
- Flash

Item no. 325-001

GoJTAG Demo Board



Simple training board for getting started with Boundary Scan technology

- 2 Boundary Scan ICs (CPLD)
- Fault switch
- Push button
- Serial Flash
- RAM
- LED

Item no. TAS-003

ESA Coach

Complex "Embedded System Access (ESA)" training board for JTAG / Boundary Scan, VarioTAP and ChipVORX applications

- Atmel AT91SAM9G45 MCU (ARM)
- Xilinx FPGA
- I2C flash
- NOR and NAND flash
- SD-DDR2 RAM
- graphic display
- analogue potentiometer
- digital I/Os

Item no. TAS-004

Integra V1

Reference board for demonstrating and qualifying JTAG/ Boundary Scan integrations in ICT / MDA / FCT / FPT

- Boundary Scan modules (FPGA, CPLD)
- Non-Boundary Scan modules (flash, RAM, display, ADC, DAC, LED, reverser)
- additional test points are available on both sides for pin access, enabling a combination of Boundary Scan and ICT / MDA / FPT operations
- simulation of production faults using fault switch
- G-TAP support
- dimensions: 160 x 100 mm

Item no. TAS-005

Software

CASCON GALAXY-DS Base Edition

JTAG/Boundary Scan software package with tools for

- Test Program Generation
  - *ATPG Infrastructure Test*
  - *ATPG Interconnection Test 1149.1*
  - *Basic Test Generation*
  - *TP Generation 1149.4*
  - *Data Import Processor*
- Data Analyzing, Visualisation and Debugging
  - *Design and Testability Explorer*
  - *Netlist Merger*
  - *Advanced Vector Browser*
  - *ScanAssist Multi Mode Debugger*
  - *ScanAssist Interactive Pin Toggler*
- Pin Failure Diagnostic Tools (PFD)
  - *PFD Infrastructure*
  - *PFD Interconnection 1149.1 und 1149.6*
  - *Universal Pin Failure Detection*
  - *Failure Diagnostics 1149.4*
- SYSTEM CASCON Platform Module
  - *Test / ISP (Batch) Execution*
  - *SX Upgrade / TAP Limit*
  - *VarioCore Handler*
  - *Hybrid Vector Splitter*
  - *SX-Upgrade / Scan Router Handler*
  - *Multi User Manager*
  - *Floating Licence Manager*
  - *Automated Process Scripting*
  - *CASCON Device Library*
  - *CASCON Full Platform License*

Item no. 211-001

CASCON GALAXY-DS Standard Edition

JTAG/Boundary Scan software package with tools for

- Test Program Generation
  - *ATPG Infrastructure Test*
  - *ATPG Interconnection Test 1149.1*
  - *ATPG Memory Access*
  - *ATPG Device Model*
  - *Basic Test Generation*
  - *TP Generation 1149.4*
- In-System Programming
  - *Basic Flash-Programming*
  - *Automated Flash Programming (AFPG)*
  - *PLD Program Generator*
  - *Data Import Processor*
- Pin Failure Diagnostics Tools (PFD)
  - *PFD Infrastructure*
  - *PFD Interconnection 1149.1 und 1149.6*
  - *PFD Memory Access*
  - *Universal Pin Failure Detection*
  - *Failure Diagnostics 1149.4*
- SYSTEM CASCON Platform Module
  - *SX Upgrade / TAP Limit*
  - *VarioCore Handler*
  - *Multi User Manager*
  - *Floating Licence Manager*
  - *CASCON Device Library*

Item no. 224-001

CASCON GALAXY-DS Classic Edition

JTAG/Boundary Scan software package with tools for

- Test Program Generation
  - *ATPG Infrastructure Test*
  - *ATPG Interconnection Test 1149.1, 1149.6*
  - *ATPG Clusters (True Table)*
  - *ATPG Clusters (Waveform)*
  - *ATPG Memory Access*
  - *ATPG Logic Components*
  - *ATPG Device Model*
  - *Basic Test Generation*
  - *TP Generation 1149.4*
  - *Basic VarioTap Test Generation*
- In-System Programming
  - *Basic Flash Programming*
  - *Automated Flash Programming (AFPG)*
  - *Automated VarioTAP Flash ISP*
  - *PLD Programm Generator*
  - *Data Import Processor*
- Data Analyzing, Visualisation and Debugging
  - *Netlist Merger*
  - *Test Coverage Analyser*
  - *Scan Vision III Layout Reader*
  - *Scan Vision III Layout*
  - *Advanced Vector Browser*
  - *Scan Assist Multi Mode Debugger*
  - *Scan Assist Interactive Pin Toggler*
- Pin Failure Diagnostic Tools (PFD)
  - *PFD Infrastructure*
  - *PFD Interconnection 1149.1 und 1149.6*
  - *PFD Memory Access*
  - *PFD Logic Components*
  - *PFD Clusters (Truth Table)*
  - *Universal Pin Failure Detection*
- SYSTEM CASCON Platform Module
  - *SX Upgrade / Multi TAP (>2)*
  - *SX Upgrade / Scan Router Handler*
  - *SX Upgrade / Scan Gang Handler*
  - *Multi User Manager (myCASCON)*
  - *Floating Licence Manager*
- Demo Board

Item no. 223-001

CASCON GALAXY-DS Advanced Edition

JTAG/Boundary Scan software package with tools for

- Program Generation
  - *ATPG Infrastructure Test*
  - *ATPG Interconnection Test 1149.1, 1149.6*
  - *ATPG Clusters (True Table)*
  - *ATPG Clusters (Waveform*
  - *ATPG Memory Access*
  - *ATPG Logic Components*
  - *ATPG Device Model*
  - *Basic Test Generation*
  - *TP Generation 1149.4*
  - *AVTG Dynamic Memory Access*
  - *Basic VarioTAP Test Generation*
  - *ATPG Flying Probe*
- In-System Programming
  - *Basic Flash Programming*
  - *Automated Flash Programming (AFPG)*
  - *Automated VarioTAP Flash Programming*
  - *Automated VarioTAP Flash Programming*
  - *PLD Program Generator*

- Data import Processor Data Analyzing, Visualisation and Debugging
  - *Netlist Merger*
  - *Test Coverage Analyzer*
  - *Scan Vision III Layout Reader*
  - *Scan Vision III Layout*
  - *Advanced Vector Browser*
  - *ScanAssist Multi Mode Debugger*
  - *ScanAssist Interactive Pin Toggler*
- Pin Failure Diagnostic Tools (PFD)
  - *PFD Infrastructure*
  - *PFD Interconnection 1149.1 und 1149.6*
  - *PFD Memory Access*
  - *PFD Logic Components*
  - *PFD Clusters (Truth Table)*
  - *PFD Flying Probe*
  - *Universal Pin Failure Detection*
  - *Failure Diagnostics 1149.4*
- SYSTEM CASCON Platform Module
  - *SX Upgrade / TAP Limit(>2)*
  - *VarioCore Handler*
  - *SX Upgrade / Scan Router Handler*
  - *SX Upgrade / Scan Gang Handler*
  - *Multi User Manager*
  - *Floating Licence Manager*
  - *CASCON Device Library*
- Demo Board

Item no. 222-001

CASCON GALAXY-TS Run Time Edition

JTAG/Boundary Scan software package with tools for

- Data Analyzing, Visualizing and Debugging
  - *Advanced Vector Browser*
- Pin Failure Diagnostic Tools (PFD)
  - *PFD Infrastructure*
  - *Universal Pin Failure Detection*
  - *Failure Diagnostics 1149.4*
- SYSTEM CASCON Platform Module
  - *VarioCore Handler*
  - *Multi User Manager*

Item no. 211-011

CASCON GALAXY-TS Failure Diagnostic Edition

JTAG/Boundary Scan software package with tools for

- Data Analysis, Visualisation and Debugging
- Pin Failure Diagnostic Tools (PFD)
  - *PFD Infrastructure*
  - *PFD Interconnection 1149.1 und 1149.6*
  - *PFD Memory Access*
  - *PFD Logic Components*
  - *PFD Clusters (Truth Table)*
  - *Universal Pin Failure Detection*
  - *Failure Diagnostics 1149.4*
- SYSTEM CASCON Platform Module
  - *SX Upgrade / TAP Limit (>2)*
  - *VarioCore Handler*
  - *SX Upgrade / Scan Router Handler*
  - *SX Upgrade / Scan Gang Handler*
  - *Multi User Manager*
  - *Floating Licence Manager*

Item no. 225-011

CASCON GALAXY-TS Diagnostic & Repair Edition

JTAG/Boundary Scan software package with tools for

- Data Analysis, Visualisation and Debugging
  - *Scan Vision III Layout*
  - *Advanced Vector Browser*
  - *ScanAssist Multi Mode Debugger*
  - *ScanAssist Interactive Pin Toggle*
- Pin Failure Diagnostic Tools (PFD)
  - *PFD Infrastructure*
  - *PFD Interconnection 1149.1 und 1149.6*
  - *PFD Memory Access*
  - *PFD Logic Components*
  - *PFD Clusters (Truth Table)*
  - *Universal Pin Failure Detection*
  - *Failure Diagnostics 1149.4*
- SYSTEM CASCON Platform Module
  - *SX Upgrade / TAP Limit (>2)*
  - *VarioCore Handler*
  - *SX Upgrade / Scan Router Handler*
  - *SX Upgrade / Scan Gang Handler*
  - *Multi User Manager*
  - *Floating Licence Manager*

Item no.	225-020

GÖPEL electronic
Enjoy Testing

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